Application/Control No. Applicant(s)/Patent Under Reexamination 10/808,425 IWASHITA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Sin J. Lee 1752 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,936,400 B2 08-2005 Α Takasu et al. 430/270.1 US-2002/0146638 A1 10-2002 Ito et al. В 430/270.1 С US-D US-US-Ε

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